

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of SOMEKH, et al. Serial No.: 10/659,902 Filed: September 11, 2003)))	Examiner: Not Assigned Art Unit: Not Assigned		
For: END POINT DETECTION FOR SPUTTERING AND RESPUTTERING							
P.O. B	issioner ox 1450 dria, VA)					
		TRAN	SMITTAL OF INFORMATION	N DISCL	OSURE STATEMENT		
Dear S	irs:						
	In acco	rdance	with 37 CFR §§ 1.56, 1.97, a	and 1.98	, enclosed please find Form PTO-		
1449 listing the attached references which might be deemed material to the examination of the							
above-identified application.							
A.	Non-E	Non-English Language References					
		Enclosed is a search report for a counterpart application.					
			The search report Examiner	has pro	vided comments on the relevancy of		
			any non-English language re	ference	s cited in the search report.		
			The specification incorporate	es comn	nents on the relevancy of Non-		
			English language references				
			Set forth below are comment	ts provid	ded by the applicant's home country		
			counsel on the relevancy of	non-Eng	glish language references:		
B.		The information disclosure statement submitted herewith is being filed					
_,					of a national application other than a		
			continued prosecution applic	•			
,					ntry into the national stage as set		
			forth in 1.491 in an internation		-		

		before the mailing date of a first Office Action on the merits; or		
	-	□ before the mailing date of a first Office Action after filing of a Request for		
		Continued Examination under 1.114.		
C.		The information disclosure statement transmitted herewith is being filed after the		
		period specified in paragraph B, but before the mailing date of a final action		
		under 1.113, a Notice of Allowance under 1.311, or an action otherwise closing		
		prosecution, and is accompanied by:		
	1)	a Statement under 1.97(e); <u>or</u>		
	2)	a fee of \$180 as set forth in 1.17(p).		
D.		The information disclosure statement transmitted herewith is being filed after the		
		period specified in paragraph C, but before payment of the issue fee, and is		
		accompanied by:		
	1)	a Statement under 1.97(e); <u>and</u>		
	2)	a fee of \$180 as set forth in 1.17(p).		
		STATEMENT UNDER 1.97(e)		
	I, the	person signing below, certify		
	. \square	that each item of information contained in the information disclosure statement		
		was first cited in any communication from a foreign patent office in a counterpart		
		foreign application not more than three months prior to the filing of the		
		statement. 37 C.F.R. §1.97(e)(1).		
		that no item of information contained in the information disclosure statement was		
		cited in a communication from a foreign patent office in a counterpart foreign		
		application, and, to the knowledge of the person signing the certification after		
		making reasonable inquiry, no item of information contained in the information		
	•	disclosure statement was known to any individual designated in 1.56(c) more		
		than three months prior to the filing of the statement 37 C.E.R. 81 97(a)(2)		

If required under paragraph B or C supra, enclosed is Applicant's check in the amount of \$180 as set forth in 1.17(p). Please charge any insufficiency or credit any overpayment to Deposit Account No. 50-0585. A duplicate of this letter is enclosed for fee processing.

Respectfully submitted,

William K. Konrad Reg. No. 28,868

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I hereby certify that this correspondence is being deposited with the United States Postal Service on the date indicated above and o: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

FORM PTO-1449 Docket Number (Optional) Application Numb r 006869USA 10/659.902 INFORMATION DIEGLASE 発 CITATION **Applicant** IN AN APPLICATION SOMEKH (Use several sheets if necessary) Filing Date **Group Art Unit** 7085 September 11, 2003 **U.S. PATENT DOCUMENTS** DATE **EXAMINER DOCUMENT NUMBER** NAME **CLASS SUBCLASS FILING** INITIAL DATE 5 6 0 5 6 11/3/92 Robbins 2 9 0 3 5 8 3 3/1/94 Koshimizu 3 5 4 7 4 6 0 9/13/94 Gifford et al. 5 7 2 8 2 5 3 3/17/98 Saito et al. 5 8 7 6 5 2/16/99 1 8 Tao et al. 7 5 9 8 0 6 7 11/9/99 Koshimizu et al. 6 1 7 3 4 8 9/12/00 Peng et al. 6 1 2 1 1 7 9/19/00 4 Daniel et al. 2 6 1 9 0 9 7 2/20/01 Liu 6 2 0 7 0 0 8 3/27/01 Kijima 6 2 5 8 4 9 7/10/01 Kropp et al. 6 2 6 5 3 1 6 7/24/01 Yoshida 6 2 9 7 0 6 10/2/01 4 Koshimizu 6 12/4/01 Lundquist et al. **FOREIGN PATENT DOCUMENTS** DATE **CLASS SUBCLASS** DOCUMENT NUMBER COUNTRY **Translation** YES NO OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.) Li, et al. US 2001/0007772 pub. 7/12/01 Radzimski, Z. J., et al. "Optical emission spectroscopy of high density metal plasma formed during magnetron sputtering." J. Vac. Sci. Tech., B 15(2), Mar/Apr 1997; pp 202-208. **DATE CONSIDERED EXAMINER**

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.